



# Isolated, Single-Channel RS-232 Line Driver/Receiver

## ADM3251E

### FEATURES

- 2.5 kV fully isolated (power and data) RS-232 transceiver
- isoPower* integrated, isolated dc-to-dc converter
- 460 kbps data rate
- 1 Tx and 1 Rx
- Meets EIA/TIA-232E specifications
- ESD protection on  $R_{IN}$  and  $T_{OUT}$  pins
  - $\pm 8$  kV: contact discharge
  - $\pm 15$  kV: air gap discharge
- 0.1  $\mu$ F charge pump capacitors
- High common-mode transient immunity:  $>25$  kV/ $\mu$ s
- Safety and regulatory approvals (pending)
  - UL recognition
    - 2500 V rms for 1 minute per UL 1577
  - VDE Certificate of Conformity
    - DIN V VDE V 0884-10 (VDE V 0884-10):2006-12
    - $V_{ORM} = 560$  V peak
- Operating temperature range:  $-40^{\circ}\text{C}$  to  $+85^{\circ}\text{C}$
- Wide body, 20-lead SOIC package

### APPLICATIONS

- High noise data communications
- Industrial communications
- General-purpose RS-232 data links
- Industrial/telecommunications diagnostic ports
- Medical equipment

### GENERAL DESCRIPTION

The ADM3251E is a high speed, 2.5 kV fully isolated, single-channel RS-232/V.28 transceiver device that operates from a single 5 V power supply. Due to the high ESD protection on the  $R_{IN}$  and  $T_{OUT}$  pins, the device is ideally suited for operation in electrically harsh environments or where RS-232 cables are frequently being plugged and unplugged.

The ADM3251E incorporates dual-channel digital isolators with *isoPower*™ integrated, isolated power. There is no requirement to use a separate isolated dc-to-dc converter. Chip-scale transformer *iCoupler*® technology from Analog Devices, Inc., is used both for the isolation of the logic signals as well as for the integrated dc-to-dc converter. The result is a total isolation solution.

### FUNCTIONAL BLOCK DIAGRAM

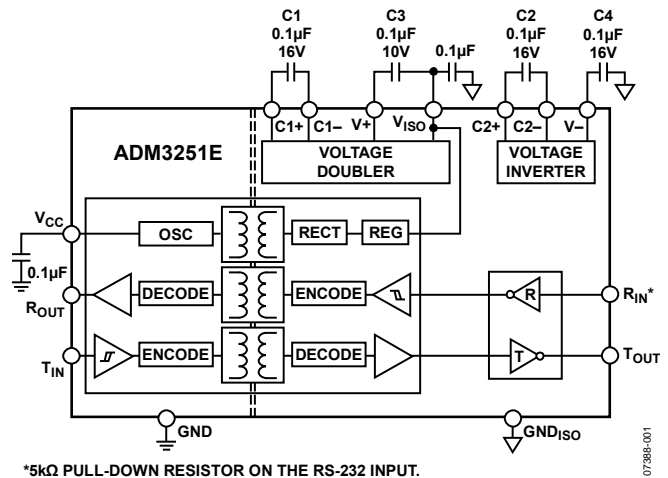


Figure 1.

The ADM3251E conforms to the EIA/TIA-232E and ITU-T V.28 specifications and operates at data rates up to 460 kbps.

Four external 0.1  $\mu$ F charge pump capacitors are used for the voltage doubler/inverter, permitting operation from a single 5 V supply.

The ADM3251E is available in a 20-lead, wide body SOIC package and is specified over the  $-40^{\circ}\text{C}$  to  $+85^{\circ}\text{C}$  temperature range.

#### Rev. 0

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TABLE OF CONTENTS

Features .....	1	Pin Configuration and Function Descriptions.....	8
Applications.....	1	Typical Performance Characteristics .....	9
Functional Block Diagram .....	1	Theory of Operation .....	11
General Description .....	1	Isolation of Power and Data.....	11
Revision History .....	2	Charge Pump Voltage Converter .....	12
Specifications.....	3	5.0 V Logic to EIA/TIA-232E Transmitter.....	12
Package Characteristics .....	5	EIA/TIA-232E to 5 V Logic Receiver .....	12
Regulatory Information (Pending) .....	5	High Baud Rate.....	12
Insulation and Safety-Related Specifications.....	5	Thermal Analysis .....	12
DIN V VDE V 0884-10 (VDE V 0884-10):2006-12 Insulation		PCB Layout .....	13
Characteristics (Pending).....	6	Insulation Lifetime .....	13
Absolute Maximum Ratings.....	7	Outline Dimensions .....	14
ESD Caution.....	7	Ordering Guide .....	14

REVISION HISTORY

7/08—Revision 0: Initial Version

## SPECIFICATIONS

All voltages are relative to their respective ground; all minimum/maximum specifications apply over the entire recommended operating range;  $T_A = 25^\circ\text{C}$  and  $V_{CC} = 5.0\text{ V}$  (dc-to-dc converter enabled), unless otherwise noted.

Table 1.

Parameter	Min	Typ	Max	Unit	Test Conditions/Comments
DC CHARACTERISTICS					
$V_{CC}$ Operating Voltage Range	4.5		5.5	V	
DC-to-DC Converter Enable Threshold, $V_{CC(ENABLE)}^1$	4.5			V	
DC-to-DC Converter Disable Threshold, $V_{CC(DISABLE)}^1$			3.7	V	
DC-to-DC Converter Enabled					
Input Supply Current, $I_{CC(ENABLE)}$			110	mA	$V_{CC} = 5.5\text{ V}$ , no load
			145	mA	$V_{CC} = 5.5\text{ V}$ , $R_L = 3\text{ k}\Omega$
$V_{ISO}$ Output <sup>2</sup>		5.0		V	$I_{ISO} = 0\text{ }\mu\text{A}$
LOGIC					
Transmitter Input, $T_{IN}$					
Logic Input Current, $I_{TIN}$	-10	+0.01	+10	$\mu\text{A}$	
Logic Low Input Threshold, $V_{TINL}$			$0.3 V_{CC}$	V	
Logic High Input Threshold, $V_{TINH}$	$0.7 V_{CC}$			V	
Receiver Output, $R_{OUT}$					
Logic High Output, $V_{ROUTH}$	$V_{CC} - 0.1$	$V_{CC}$		V	$I_{ROUTH} = -20\text{ }\mu\text{A}$
	$V_{CC} - 0.5$	$V_{CC} - 0.3$		V	$I_{ROUTH} = -4\text{ mA}$
Logic Low Output, $V_{ROUTL}$		0.0	0.1	V	$I_{ROUTH} = 20\text{ }\mu\text{A}$
		0.3	0.4	V	$I_{ROUTH} = 4\text{ mA}$
RS-232					
Receiver, $R_{IN}$					
EIA-232 Input Voltage Range <sup>3</sup>	-30		+30	V	
EIA-232 Input Threshold Low	0.6	2.0		V	
EIA-232 Input Threshold High		2.1	2.4	V	
EIA-232 Input Hysteresis		0.1		V	
EIA-232 Input Resistance	3	5	7	$\text{k}\Omega$	
Transmitter, $T_{OUT}$					
Output Voltage Swing (RS-232)	$\pm 5$	$\pm 5.7$		V	$R_L = 3\text{ k}\Omega$ to GND
Transmitter Output Resistance	300			$\Omega$	$V_{ISO} = 0\text{ V}$
Output Short-Circuit Current (RS-232)		$\pm 12$		mA	
TIMING CHARACTERISTICS					
Maximum Data Rate	460			kbps	$R_L = 3\text{ k}\Omega$ to $7\text{ k}\Omega$ , $C_L = 50\text{ pF}$ to $1000\text{ pF}$
Receiver Propagation Delay					
$t_{PHL}$		190		$\mu\text{s}$	
$t_{PLH}$		135		$\mu\text{s}$	
Transmitter Propagation Delay		650		$\mu\text{s}$	$R_L = 3\text{ k}\Omega$ , $C_L = 1000\text{ pF}$
Transmitter Skew		80		ns	
Receiver Skew		70		ns	
Transition Region Slew Rate <sup>3</sup>	5.5	10	30	V/ $\mu\text{s}$	+3 V to -3 V or -3 V to +3 V, $V_{CC} = +3.3\text{ V}$ , $R_L = 3\text{ k}\Omega$ , $C_L = 1000\text{ pF}$ , $T_A = 25^\circ\text{C}$
AC SPECIFICATIONS					
Output Rise/Fall Time, $t_R/t_F$ (10% to 90%)		2.3		ns	$C_L = 15\text{ pF}$ , CMOS signal levels
Common-Mode Transient Immunity at Logic High Output <sup>4</sup>	25			kV/ $\mu\text{s}$	$V_{CM} = 1\text{ kV}$ , transient magnitude = 800 V
Common-Mode Transient Immunity at Logic Low Output <sup>4</sup>	25			kV/ $\mu\text{s}$	$V_{CM} = 1\text{ kV}$ , transient magnitude = 800 V
ESD PROTECTION ( $R_{IN}$ And $T_{OUT}$ PINS)					
		$\pm 15$		kV	Human body model air discharge
		$\pm 8$		kV	Human body model contact discharge

<sup>1</sup> Enable/disable threshold is the  $V_{CC}$  voltage at which the internal dc-to-dc converter is enabled/disabled.

<sup>2</sup> To maintain data sheet specifications, do not draw current from  $V_{ISO}$ .

<sup>3</sup> Guaranteed by design.

<sup>4</sup> CM is the maximum common-mode voltage slew rate that can be sustained while maintaining specification-compliant operation.  $V_{CM}$  is the common-mode potential difference between the logic and bus sides. The transient magnitude is the range over which the common mode is slewed. The common-mode voltage slew rates apply to both rising and falling common-mode voltage edges.

# ADM3251E

All voltages are relative to their respective ground; all minimum/maximum specifications apply over the entire recommended operating range;  $T_A = 25^\circ\text{C}$ ,  $V_{CC} = 3.3\text{ V}$  (dc-to-dc converter disabled), and the secondary side is powered externally by  $V_{ISO} = 3.3\text{ V}$ , unless otherwise noted.

**Table 2.**

Parameter	Min	Typ	Max	Unit	Test Conditions/Comments
<b>DC CHARACTERISTICS</b>					
$V_{CC}$ Operating Voltage Range	3.0		3.7	V	
DC-to-DC Converter Disable Threshold, $V_{CC(DISABLE)}$ <sup>1</sup>			3.7	V	
DC-to-DC Converter Disabled					
$V_{ISO}$ <sup>2</sup>	3.0		5.5	V	
Primary Side Supply Input Current, $I_{CC(DISABLE)}$			1.5	mA	No load
Secondary Side Supply Input Current, $I_{ISO(DISABLE)}$			12	mA	$V_{ISO} = 5.5\text{ V}$ , $R_L = 3\text{ k}\Omega$
Secondary Side Supply Input Current, $I_{ISO(DISABLE)}$		6.2		mA	$R_L = 3\text{ k}\Omega$
<b>LOGIC</b>					
Transmitter Input, $T_{IN}$					
Logic Input Current, $I_{TIN}$	-10	+0.01	+10	$\mu\text{A}$	
Logic Low Input Threshold, $V_{TINL}$			0.3 $V_{CC}$	V	
Logic High Input Threshold, $V_{TINH}$	0.7 $V_{CC}$			V	
Receiver Output, $R_{OUT}$					
Logic High Output, $V_{ROUTH}$	$V_{CC} - 0.1$	$V_{CC}$		V	$I_{ROUTH} = -20\text{ }\mu\text{A}$
	$V_{CC} - 0.5$	$V_{CC} - 0.3$		V	$I_{ROUTH} = -4\text{ mA}$
		0.0	0.1	V	$I_{ROUTH} = 20\text{ }\mu\text{A}$
		0.3	0.4	V	$I_{ROUTH} = 4\text{ mA}$
<b>RS-232</b>					
Receiver, $R_{IN}$					
EIA-232 Input Voltage Range <sup>3</sup>	-30		+30	V	
EIA-232 Input Threshold Low	0.6	1.3		V	
EIA-232 Input Threshold High		1.6	2.4	V	
EIA-232 Input Hysteresis		0.3		V	
EIA-232 Input Resistance	3	5	7	k $\Omega$	
Transmitter, $T_{OUT}$					
Output Voltage Swing (RS-232)	$\pm 5$	$\pm 5.7$		V	$R_L = 3\text{ k}\Omega$ to GND
Transmitter Output Resistance	300			$\Omega$	$V_{ISO} = 0\text{ V}$
Output Short-Circuit Current (RS-232)		$\pm 11$		mA	
<b>TIMING CHARACTERISTICS</b>					
Maximum Data Rate	460			kbps	$R_L = 3\text{ k}\Omega$ to 7 k $\Omega$ , $C_L = 50\text{ pF}$ to 1000 pF
Receiver Propagation Delay					
$t_{PHL}$		190		$\mu\text{s}$	
$t_{PLH}$		135		$\mu\text{s}$	
Transmitter Propagation Delay		650		$\mu\text{s}$	$R_L = 3\text{ k}\Omega$ , $C_L = 1000\text{ pF}$
Transmitter Skew		80		ns	
Receiver Skew		55		ns	
Transition Region Slew Rate <sup>3</sup>	5.5	10	30	V/ $\mu\text{s}$	+3 V to -3 V or -3 V to +3 V, $V_{CC} = 3.3\text{ V}$ , $R_L = 3\text{ k}\Omega$ , $C_L = 1000\text{ pF}$ , $T_A = 25^\circ\text{C}$
<b>AC SPECIFICATIONS</b>					
Output Rise/Fall Time, $t_R/t_F$ (10% to 90%)		2.3		ns	$C_L = 15\text{ pF}$ , CMOS signal levels
Common-Mode Transient Immunity at Logic High Output <sup>4</sup>	25			kV/ $\mu\text{s}$	$V_{CM} = 1\text{ kV}$ , transient magnitude = 800 V
Common-Mode Transient Immunity at Logic Low Output <sup>4</sup>	25			kV/ $\mu\text{s}$	$V_{CM} = 1\text{ kV}$ , transient magnitude = 800 V
<b>ESD PROTECTION (<math>R_{IN}</math> AND <math>T_{OUT}</math> PINS)</b>					
		$\pm 15$		kV	Human body model air discharge
		$\pm 8$		kV	Human body model contact discharge

<sup>1</sup> Enable/disable threshold is the  $V_{CC}$  voltage at which the internal dc-to-dc converter is enabled/disabled.

<sup>2</sup> To maintain data sheet specifications, do not draw current from  $V_{ISO}$ .

<sup>3</sup> Guaranteed by design.

<sup>4</sup> CM is the maximum common-mode voltage slew rate that can be sustained while maintaining specification-compliant operation.  $V_{CM}$  is the common-mode potential difference between the logic and bus sides. The transient magnitude is the range over which the common mode is slewed. The common-mode voltage slew rates apply to both rising and falling common-mode voltage edges.

## PACKAGE CHARACTERISTICS

Table 3.

Parameter	Symbol	Min	Typ	Max	Unit	Test Conditions
Resistance (Input-Output)	$R_{I-O}$		$10^{12}$		$\Omega$	f = 1 MHz
Capacitance (Input-Output)	$C_{I-O}$		2.2		pF	
Input Capacitance	$C_I$		4.0		pF	
IC Junction-to-Air Thermal Resistance	$\theta_{JA}$		47.05		$^{\circ}\text{C/W}$	

## REGULATORY INFORMATION (PENDING)

Table 4.

UL <sup>1</sup>	VDE
1577 Component Recognition Program (Pending) Single/Basic Insulation, 2500 V rms Isolation Rating	To be certified according to DIN V VDE V 0884-10 (VDE V 0884-10):2006-12 <sup>2</sup> Reinforced insulation, 560 V peak

<sup>1</sup> In accordance with UL 1577, each ADM3251E is proof-tested by applying an insulation test voltage  $\geq 3000$  V rms for 1 sec (current leakage detection limit = 5  $\mu\text{A}$ ).

<sup>2</sup> In accordance with DIN V VDE V 0884-10, each ADM3251E is proof-tested by applying an insulation test voltage  $\geq 1050$  V peak for 1 sec (partial discharge detection limit = 5 pC).

## INSULATION AND SAFETY-RELATED SPECIFICATIONS

Table 5.

Parameter	Symbol	Value	Unit	Conditions
Rated Dielectric Insulation Voltage		2500	V rms	1 minute duration
Minimum External Air Gap (Clearance)	L(I01)	7.7	mm	Measured from input terminals to output terminals, shortest distance through air
Minimum External Tracking (Creepage)	L(I02)	4.16	mm	Measured from input terminals to output terminals, shortest distance path along body
Minimum Internal Gap (Internal Clearance)		0.017	mm	Distance through insulation
Tracking Resistance (Comparative Tracking Index)	CTI	>175	V	DIN IEC 112/VDE 0303 Part 1
Isolation Group		IIIa		Material group (DIN VDE 0110, 1/89, Table 1)
Maximum Working Voltage Compatible with 50-Year Service Life	$V_{IORM}$	425	V peak	Continuous peak voltage across the isolation barrier

# ADM3251E

## DIN V VDE V 0884-10 (VDE V 0884-10):2006-12 INSULATION CHARACTERISTICS (PENDING)

This isolator is suitable for reinforced isolation only within the safety limit data. Maintenance of the safety data is ensured by protective circuits.

Table 6.

Description	Conditions	Symbol	Characteristic	Unit
Installation Classification per DIN VDE 0110 For Rated Mains Voltage $\leq 150$ V rms For Rated Mains Voltage $\leq 300$ V rms			I to IV I to III 40/105/21	
Climatic Classification			2	
Pollution Degree (DIN VDE 0110, Table 1)				
Maximum Working Insulation Voltage		$V_{IORM}$	424	V peak
Input-to-Output Test Voltage Method b1	$V_{IORM} \times 1.875 = V_{PR}$ , 100% production test, $t_m = 1$ sec, partial discharge $< 5$ pC	$V_{PR}$	795	V peak
Method a After Environmental Test Subgroup 1	$V_{IORM} \times 1.6 = V_{PR}$ , $t_m = 60$ sec, partial discharge $< 5$ pC	$V_{PR}$	680	V peak
After Input and/or Safety Subgroup 2/Subgroup 3	$V_{IORM} \times 1.2 = V_{PR}$ , $t_m = 60$ sec, partial discharge $< 5$ pC	$V_P$	510	V peak
Highest Allowable Overvoltage	Transient overvoltage, $t_{TR} = 10$ sec	$V_{TR}$	4000	V peak
Safety-Limiting Values	Maximum value allowed in the event of a failure			
Case Temperature		$T_S$	150	°C
Supply Current		$I_{S1}$	531	mA
Insulation Resistance at $T_S$	$V_{IO} = 500$ V	$R_S$	$> 10^9$	$\Omega$

## ABSOLUTE MAXIMUM RATINGS

Table 7.

Parameter	Rating
$V_{CC}, V_{ISO}$	–0.3 V to +6 V
$V+$	$(V_{CC} - 0.3 \text{ V})$ to +13 V
$V-$	–13 V to +0.3 V
Input Voltages	
$T_{IN}$	–0.3 V to $(V_{CC} + 0.3 \text{ V})$
$R_{IN}$	$\pm 30 \text{ V}$
Output Voltages	
$T_{OUT}$	$\pm 15 \text{ V}$
$R_{OUT}$	–0.3 V to $(V_{CC} + 0.3 \text{ V})$
Short-Circuit Duration	
$T_{OUT}$	Continuous
Power Dissipation	
$\theta_{JA}$ , Thermal Impedance	47.05°C/W
Operating Temperature Range	
Industrial	–40°C to +85°C
Storage Temperature Range	–65°C to +150°C
Pb-Free Temperature (Soldering, 30 sec)	260°C

Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational section of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

### ESD CAUTION



**ESD (electrostatic discharge) sensitive device.** Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

# ADM3251E

## PIN CONFIGURATION AND FUNCTION DESCRIPTIONS

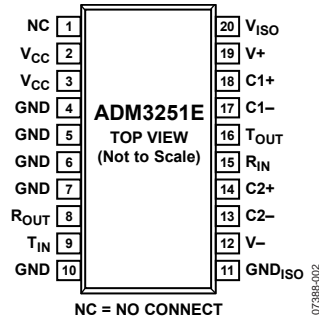


Figure 2. Pin Configuration

Table 8. Pin Function Descriptions

Pin No.	Mnemonic	Description
1	NC	No Connect. This pin should always remain unconnected.
2, 3	V <sub>CC</sub>	Power Supply Input. A 0.1 $\mu$ F decoupling capacitor is required between V <sub>CC</sub> and ground. When a voltage between 4.5 V and 5.5 V is applied to the V <sub>CC</sub> pin, the integrated dc-to-dc converter is enabled. If this voltage is lowered to between 3.0 V and 3.7 V, the integrated dc-to-dc converter is disabled.
4, 5, 6, 7, 10	GND	Ground Pin.
8	R <sub>OUT</sub>	Receiver Output. This pin outputs CMOS logic levels.
9	T <sub>IN</sub>	Transmitter (Driver) Input. This pin accepts TTL/CMOS levels.
11	GND <sub>ISO</sub>	Ground Reference for Isolator Primary Side.
12	V <sub>-</sub>	Internally Generated Negative Supply.
13, 14	C2 <sub>-</sub> , C2 <sub>+</sub>	Positive and Negative Connections for Charge Pump Capacitors. External Capacitor C2 is connected between these pins; a 0.1 $\mu$ F capacitor is recommended, but larger capacitors up to 10 $\mu$ F can be used.
15	R <sub>IN</sub>	Receiver Input. This input accepts RS-232 signal levels.
16	T <sub>OUT</sub>	Transmitter (Driver) Output. This outputs RS-232 signal levels.
17, 18	C1 <sub>-</sub> , C1 <sub>+</sub>	Positive and Negative Connections for Charge Pump Capacitors. External Capacitor C1 is connected between these pins; a 0.1 $\mu$ F capacitor is recommended, but larger capacitors up to 10 $\mu$ F can be used.
19	V <sub>+</sub>	Internally Generated Positive Supply.
20	V <sub>ISO</sub>	Isolated Supply Voltage for Isolator Secondary Side. A 0.1 $\mu$ F decoupling capacitor is required between V <sub>ISO</sub> and ground. When the integrated dc-to-dc converter is enabled, the V <sub>ISO</sub> pin should not be used to power external circuitry. If the integrated dc-to-dc converter is disabled, power the secondary side by applying a voltage in the range of 3.0 V to 5.5 V to this pin.



## TYPICAL PERFORMANCE CHARACTERISTICS

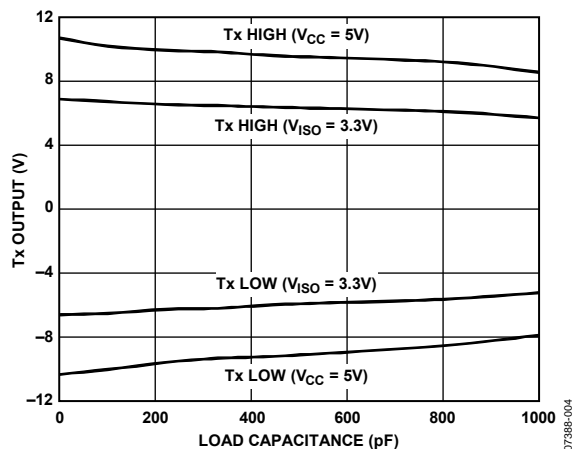


Figure 3. Transmitter Output Voltage High/Low vs. Load Capacitance @ 460 kbps

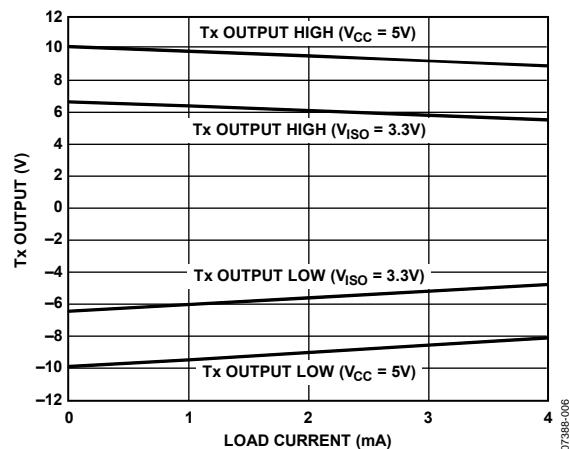


Figure 6. Transmitter Output Voltage High/Low vs. Load Current

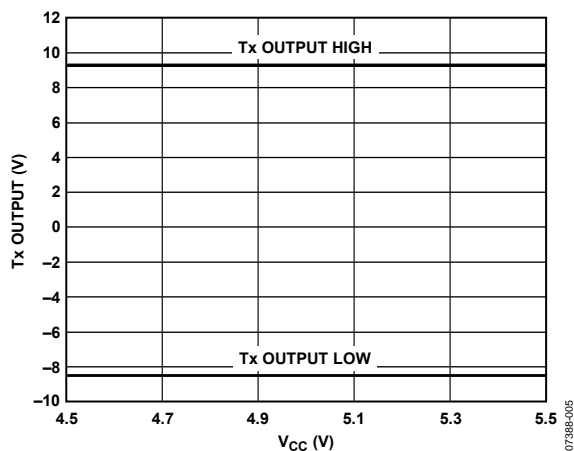


Figure 4. Transmitter Output Voltage High/Low vs.  $V_{CC}$ ,  $R_L = 3\text{ k}\Omega$

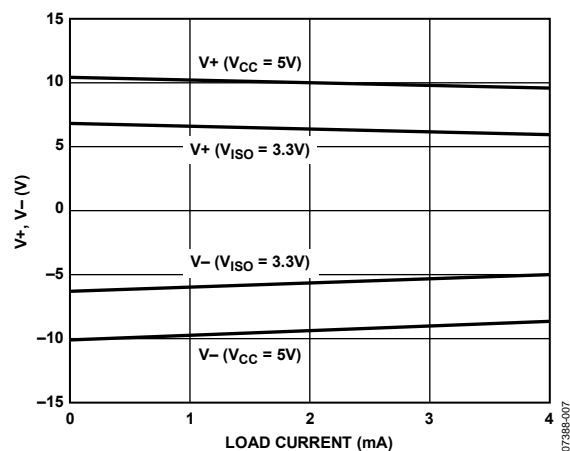


Figure 7. Charge Pump  $V_+$ ,  $V_-$  vs. Load Current

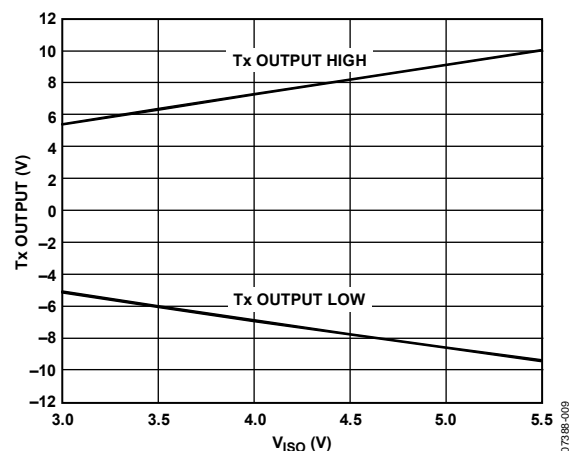


Figure 5. Transmitter Output Voltage High/Low vs.  $V_{ISO}$ ,  $R_L = 3\text{ k}\Omega$

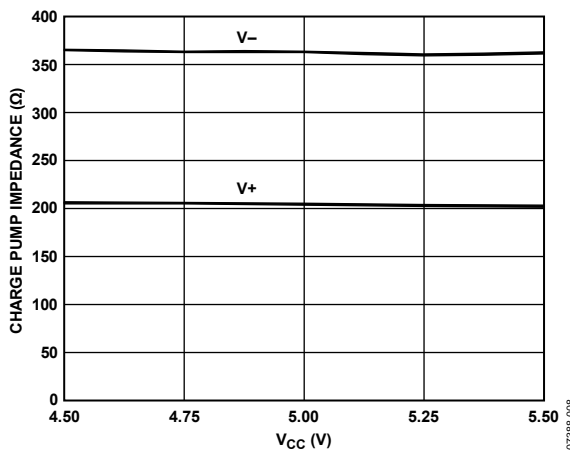


Figure 8. Charge Pump Impedance vs.  $V_{CC}$

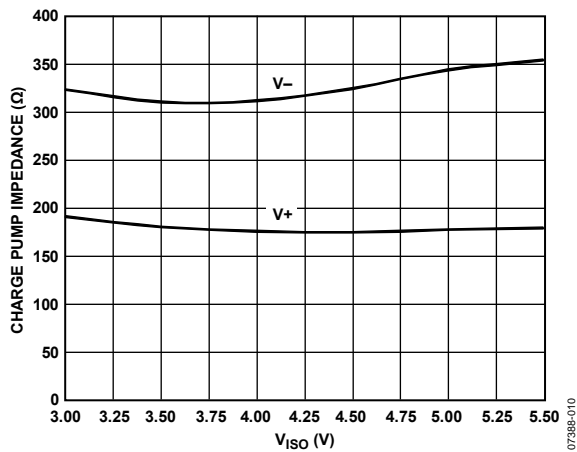


Figure 9. Charge Pump Impedance vs.  $V_{ISO}$

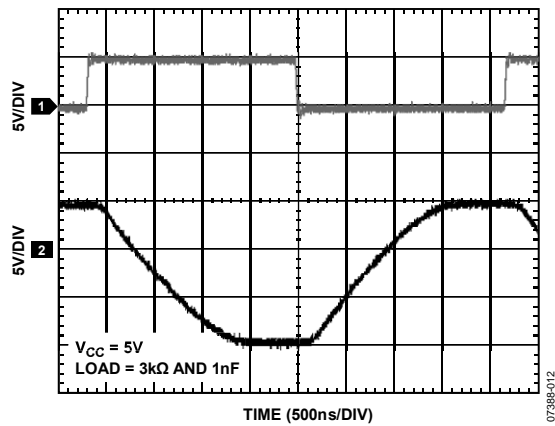


Figure 11. 460 kbps Data Transmission

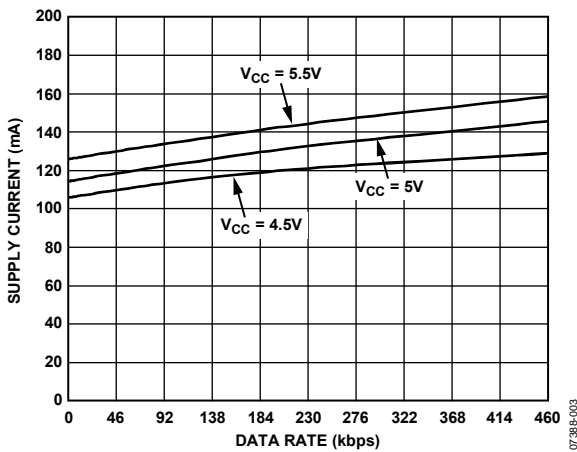


Figure 10. Primary Supply Current vs. Data Rate

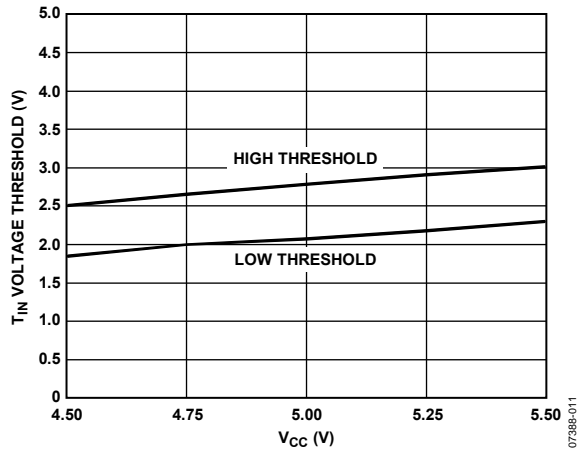


Figure 12.  $T_{IN}$  Voltage Threshold vs.  $V_{CC}$



# ADM3251E

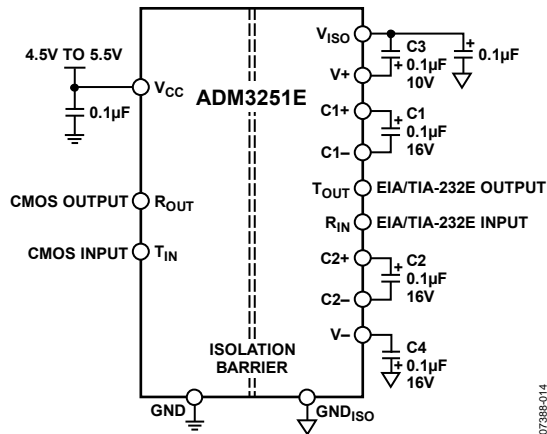


Figure 14. Typical Operating Circuit with the DC-to-DC Converter Enabled ( $V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$ )

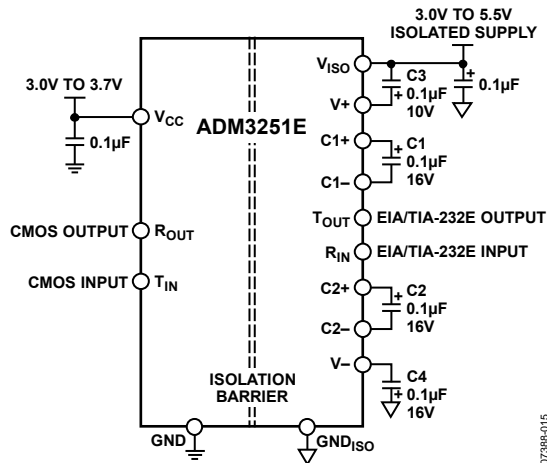


Figure 15. Typical Operating Circuit with the DC-to-DC Converter Disabled ( $V_{CC} = 3.0 \text{ V to } 3.7 \text{ V}$ )

## CHARGE PUMP VOLTAGE CONVERTER

The charge pump voltage converter consists of a 200 kHz oscillator and a switching matrix. The converter generates a  $\pm 10.0 \text{ V}$  supply from the input 5.0 V level. This is done in two stages by using a switched capacitor technique as illustrated in Figure 16 and Figure 17. First, the 5.0 V input supply is doubled to 10.0 V by using C1 as the charge storage element. The +10.0 V level is then inverted to generate  $-10.0 \text{ V}$  using C2 as the storage element. C3 is shown connected between V+ and VISO, but is equally effective if connected between V+ and GNDISO.

Capacitors C3 and C4 are used to reduce the output ripple. Their values are not critical and can be increased, if desired. Larger capacitors (up to 10  $\mu\text{F}$ ) can be used in place of capacitors C1, C2, C3, and C4.

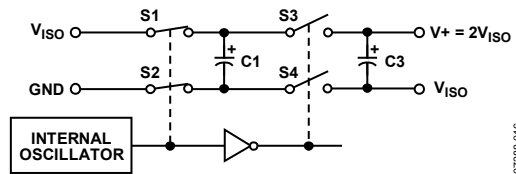


Figure 16. Charge Pump Voltage Doubler

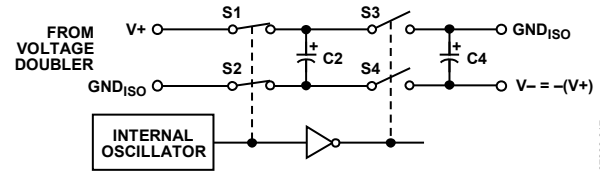


Figure 17. Charge Pump Voltage Inverter

## 5.0 V LOGIC TO EIA/TIA-232E TRANSMITTER

The transmitter driver converts the 5.0 V logic input levels into RS-232 output levels. When driving an RS-232 load with  $V_{CC} = 5.0 \text{ V}$ , the output voltage swing is typically  $\pm 10 \text{ V}$ .

## EIA/TIA-232E TO 5 V LOGIC RECEIVER

The receiver is an inverting level-shifter that accepts the RS-232 input level and translates it into a 5.0 V logic output level. The input has an internal 5 k $\Omega$  pull-down resistor to ground and is also protected against overvoltages of up to  $\pm 30 \text{ V}$ . An unconnected input is pulled to 0 V by the internal 5 k $\Omega$  pull-down resistor. This, therefore, results in a Logic 1 output level for an unconnected input or for an input connected to GND. The receiver has a Schmitt-trigger input with a hysteresis level of 0.1 V. This ensures error-free reception for both a noisy input and for an input with slow transition times.

## HIGH BAUD RATE

The ADM3251E offers high slew rates, permitting data transmission at rates well in excess of the EIA/TIA-232E specifications. The RS-232 voltage levels are maintained at data rates up to 460 kbps.

## THERMAL ANALYSIS

Each ADM3251E device consists of three internal die, attached to a split-paddle lead frame. For the purposes of thermal analysis, it is treated as a thermal unit with the highest junction temperature reflected in the  $\theta_{JA}$  value from Table 7. The value of  $\theta_{JA}$  is based on measurements taken with the part mounted on a JEDEC standard 4-layer PCB with fine-width traces in still air. Following the recommendations in the PCB Layout section decreases the thermal resistance to the PCB, allowing increased thermal margin at high ambient temperatures.

## PCB LAYOUT

The ADM3251E requires no external circuitry for its logic interfaces. Power supply bypassing is required at the input and output supply pins (see Figure 18).

The power supply section of the ADM3251E uses a 300 MHz oscillator frequency to pass power through its chip-scale transformers. In addition, the normal operation of the data section of the iCoupler introduces switching transients on the power supply pins. Low inductance capacitors are required to bypass noise generated at the switching frequency as well as 1 ns pulses generated by the data transfer and dc refresh circuitry. The total lead length between both ends of the capacitor and the input power supply pin should not exceed 20 mm.

In cases where EMI emission is a concern, series inductance can be added to critical power and ground traces. Discrete inductors should be added to the line such that the high frequency bypass capacitors are between the inductor and the ADM3251E device pin. Inductance can be added in the form of discrete inductors or ferrite beads added to both power and ground traces. The recommended value corresponds to impedance between 50  $\Omega$  and 100  $\Omega$  at approximately 300 MHz.

In applications involving high common-mode transients, care should be taken to ensure that board coupling across the isolation barrier is minimized. Furthermore, the board layout should be designed such that any coupling that does occur equally affects all pins on a given component side. Failure to ensure this can cause voltage differentials between pins to exceed the absolute maximum ratings of the device, thereby leading to latch-up and/or permanent damage.

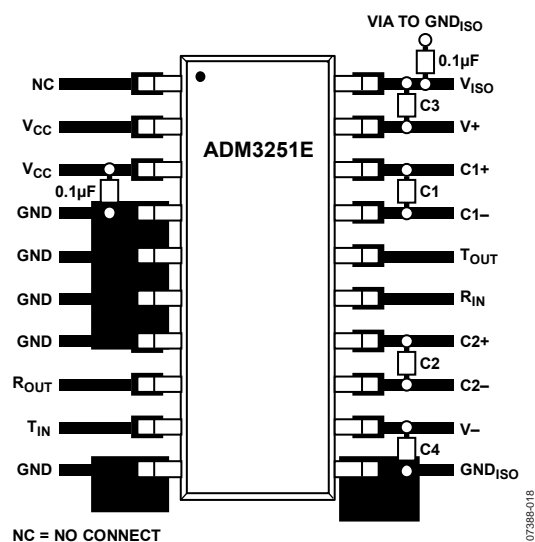


Figure 18. Recommended Printed Circuit Board Layout

Because it is not possible to apply a heat sink to an isolation device, the device primarily depends on heat dissipating into the PCB through the GND pins. If the device is used at high ambient temperatures, care should be taken to provide a thermal path from the GND pins to the PCB ground plane. The board layout in Figure 18 shows enlarged pads for Pin 4, Pin 5, Pin 6, Pin 7, Pin 10, and Pin 11. Multiple vias should be implemented from each of the pads to the ground plane, which significantly reduce the temperatures inside the chip. The dimensions of the expanded pads are left to the discretion of the designer and the available board space.

## INSULATION LIFETIME

All insulation structures eventually break down when subjected to voltage stress over a sufficiently long period. The rate of insulation degradation is dependent on the characteristics of the voltage waveform applied across the insulation. In addition to the testing performed by the regulatory agencies, Analog Devices carries out an extensive set of evaluations to determine the lifetime of the insulation structure within the ADM3251E.

The insulation lifetime of the ADM3251E depends on the voltage waveform type imposed across the isolation barrier. The iCoupler insulation structure degrades at different rates depending on whether the waveform is bipolar ac, unipolar ac, or dc. Figure 19, Figure 20, and Figure 21 illustrate these different isolation voltage waveforms.

Bipolar ac voltage is the most stringent environment. In the case of unipolar ac or dc voltage, the stress on the insulation is significantly lower.

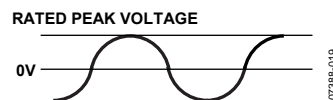


Figure 19. Bipolar AC Waveform

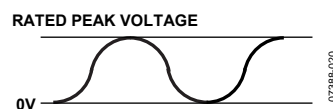


Figure 20. Unipolar AC Waveform

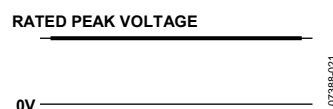
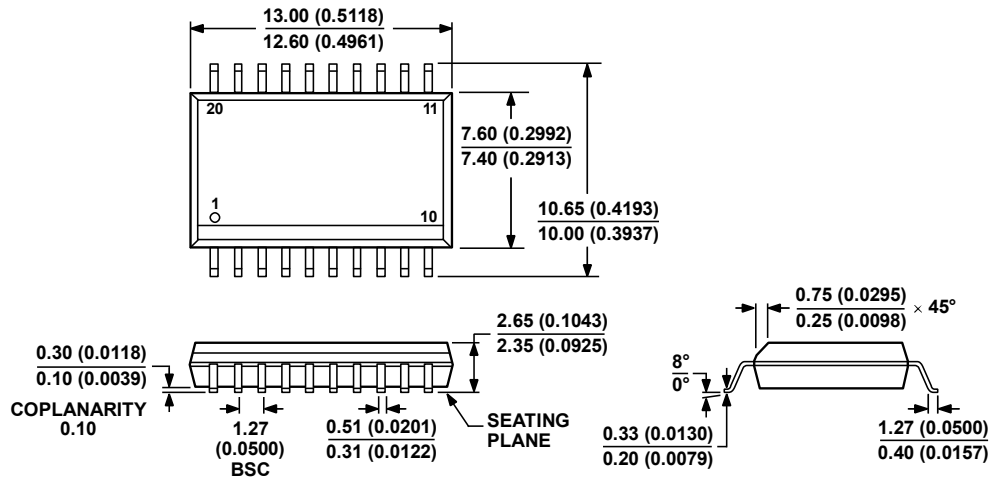


Figure 21. DC Waveform Outline Dimensions

## OUTLINE DIMENSIONS



COMPLIANT TO JEDEC STANDARDS MS-013-AC  
CONTROLLING DIMENSIONS ARE IN MILLIMETERS; INCH DIMENSIONS  
(IN PARENTHESES) ARE ROUNDED-OFF MILLIMETER EQUIVALENTS FOR  
REFERENCE ONLY AND ARE NOT APPROPRIATE FOR USE IN DESIGN.

Figure 22. 20-Lead Standard Small Outline Package [SOIC\_W]  
Wide Body  
(RW-20)

Dimensions shown in millimeters and (inches)

060706-A

## ORDERING GUIDE

Model	Temperature Range	Package Description	Package Option
ADM3251EARWZ <sup>1</sup>	−40°C to +85°C	20-Lead Standard Small Outline Package [SOIC_W]	RW-20
ADM3251EARWZ-REEL <sup>1</sup>	−40°C to +85°C	20-Lead Standard Small Outline Package [SOIC_W]	RW-20

<sup>1</sup> Z = RoHS Compliant Part.

NOTES

**ADM3251E**

## **NOTES**